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Application/Control No.	Applicant(s)/Patent under Reexamination
09/926,007	NISHIBE ET AL.
Examiner	Art Unit
Philip C. Lee	2154

SEARCHED				
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

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Keywords Search in EAST	1/9/2006	PL
Keywords Search in EAST	1/10/2006	PL